

SEMICONDUCTOR TEST PROBE

P-28025PM-300P

Pitch 0.8mm – 1.0mm

Mechanical:

- Work Force: 32gf@ 0.4mm
- Recommend Travel: 0.4mm/Full Travel 0.5mm
- Mechanical Life: 300K(Typical)
- Operating Temp: -55 °C to 125 °C
- Tip (Device Side): 4pt Crown

Electrical Characteristics:

- Pattern: GSG @ 0.65mm Pitch 
- Characteristic Impedance: 52.6ohm
- Loop Inductance: 0.58nH
- Capacitance: 0.21pF
- Bandwidth @ -1dB (Field): 38GHz
- Contact Resistance Average: <80 mΩ
- Current Carrying Capability: 2A

